



BSI Standards Publication

Semiconductor devices — Mechanical and climatic test methods

Part 30: Preconditioning of non-hermetic surface mount devices prior to reliability testing

National foreword

This British Standard is the UK implementation of EN IEC 60749-30:2020. It is identical to IEC 60749-30:2020. It supersedes BS EN 60749-30:2005+A1:2011, which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee EPL/47, Semiconductors.

A list of organizations represented on this committee can be obtained on request to its committee manager.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

© The British Standards Institution 2020
Published by BSI Standards Limited 2020

ISBN 978 0 539 04583 3

ICS 31.080.01

Compliance with a British Standard cannot confer immunity from legal obligations.

This British Standard was published under the authority of the Standards Policy and Strategy Committee on 30 September 2020.

Amendments/corrigenda issued since publication

Date	Text affected
------	---------------
